



STIC EIC 2100 1.27576 Search Request Form 66

Today's Date:

7/18/04

What date would you like to use to limit the search?

Priority Date:

7/29/2001

Other:

Name FRED EICHENIA

AU 2172

Examiner #

~~97919~~ 79719

Room # 4043

Phone

305-8037

Serial #

09919186

Format for Search Results (Circle One):

PAPER

DISK

EMAIL

Where have you searched so far?

USP DWPI EPO JPO ACM IBM TDB

IEEE INSPEC SPI

Other

Is this a "Fast & Focused" Search Request? (Circle One) YES NO

A "Fast & Focused" Search is completed in 2-3 hours (maximum). The search must be on a very specific topic and meet certain criteria. The criteria are posted in EIC2100 and on the EIC2100 NPL Web Page at <http://ptoweb/patents/stic/stic-tc2100.htm>.

What is the topic, novelty, motivation, utility, or other specific details defining the desired focus of this search? Please include the concepts, synonyms, keywords, acronyms, definitions, strategies, and anything else that helps to describe the topic. Please attach a copy of the abstract, background, brief summary, pertinent claims and any citations of relevant art you have found.

COMPACT Garbage Collection Tables

Please see attached abstract, Background & Summary of Invention for description of Terms.

Please concentrate on attached claim 1, with key terms: Call stack, garbage collection tables, call site, call site identifier, Unique descriptor, heap, 1st unique descriptor, registers, pointers

STIC Searcher

Geoffrey St-Leger

Phone

308-7800

Date picked up

7/20/04

Date Completed

7/20/04





STIC Search Report

EIC 2100

STIC Database Tracking Number: 127576

TO: Fred Ehichoya
Location: 4D43
Art Unit : 2172
Tuesday, July 20, 2004

Case Serial Number: 09/919186

From: Geoffrey St. Leger
Location: EIC 2100
PK2-4B30
Phone: 308-7800

geoffrey.stleger@uspto.gov

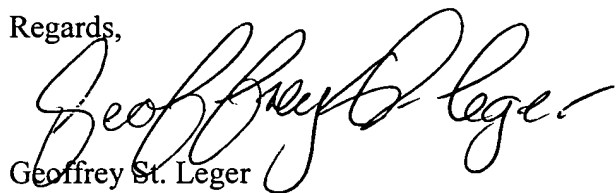
Search Notes

Dear Examiner Ehichoya,

Attached please find the results of your search request for application 09/919186. I searched Dialog's foreign patent files, technical databases, product announcement files and general files.

Please let me know if you have any questions.

Regards,



Geoffrey St. Leger
4B30/308-7800



STIC Search Results Feedback Form

EIC 2100

Questions about the scope or the results of the search? Contact *the EIC searcher or contact:*

Anne Hendrickson, EIC 2100 Team Leader
308-7831, CPK2-4B40

Voluntary Results Feedback Form

➤ I am an examiner in Workgroup: Example: 2133

➤ Relevant prior art **found**, search results used as follows:

- ☐ 102 rejection
- ☐ 103 rejection
- ☐ Cited as being of interest.
- ☐ Helped examiner better understand the invention.
- ☐ Helped examiner better understand the state of the art in their technology.

Types of relevant prior art found:

- ☐ Foreign Patent(s)
- ☐ Non-Patent Literature
(journal articles, conference proceedings, new product announcements etc.)

➤ Relevant prior art **not found**:

- ☐ Results verified the lack of relevant prior art (helped determine patentability).
- ☐ Results were not useful in determining patentability or understanding the invention.

Comments:

Drop off or send completed forms to STIC/EIC2100 CPK2-4B40

